Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/696,247	CHIN ET AL.	
Examiner	Art Unit	
Davienne Monbleau	2878	

	SEARCHED			
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED			
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SEARCH NO (INCLUDING SEARCH		)
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updated search EAST- USPGPUB, USPAT, EPO, JPO, DERWENT	2/19/2006	DM